


<b>Search Notes</b>  	<b>Application/Control No.</b>  10578875	<b>Applicant(s)/Patent Under Reexamination</b>  OYAMA, TOSHIRO
	<b>Examiner</b>  Steven D Maki	<b>Art Unit</b>  1791

SEARCHED			
Class	Subclass	Date	Examiner
152	209.18, 209.19, 209.21, 209.22, DIG 1	03/23/09	/SM/

SEARCH NOTES		
Search Notes	Date	Examiner
groove cross section digest kept in examiner's office	03/23/09	/SM/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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